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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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Reliability Report 1SC0450E2A0

Scope

The goal of this document is to explain reliability tests done on 1SC0450E2A0 family. Following drivers are covered by this family:

- 1SC0450E2A0-45
- 1SC0450E2A0-65

Serial Environmental Load

Serial stress: all the tests in the table below are done on the same samples

Test Name	Test Settings	Results
Vibration	IEC 60068-2-6:2007-12: Frequency range: 5Hz to 200Hz	Pass
(sinusoidal)	Cross-over frequency: 8.4Hz	
	Displacement amplitude below cross-over frequency: ±3.5mm	
	Acceleration amplitude above cross-over frequency: 1g	
	Sweep rate: 1.0 Okt/min	
	Test duration per axis: 20 sweeps (X, Y and Z)	
	DUT not powered	
Shock	IEC 60068-2-27:2008-02: Pulse shape: Half-sine	Pass
	Peak acceleration: 15g	
	Corresponding duration of the nominal pulse: 6ms	
	Number of shocks in each of the six directions: 100	
	Axis: X, Y and Z (pos. and neg.)	
	DUT not powered	
Cold	IEC 60068-2-1:2007-03: Test: Ae	Pass
	Temperature: -40°C	
	Duration: 96h	
	DUT powered	
Dry heat	IEC 60068-2-2:2007-07: Test:Be	Pass
	Temperature: 85°C	
	Duration: 96h	
	DUT powered	
Change of	IEC 60068-2-14:2009-01: Test: Nb	Pass
temperature	Cycles: 2	
	Start temperature: 20°C	
	Low temperature: -40°C	
	High temperature: 85°C	
	Rate of change: 10K/min	
	Exposure time at lower/upper temperature: 30min	
	DUT powered	
Damp heat	IEC 60068-2-78:2012-10: Temperature: 40°C	Pass
	Relative humidity: 93%	
	Duration of test: 96h	
	DUT not powered	